Application/Control No.	Applicant(s)/Patent under Reexamination	
10/740,464	YOO ET AL.	
Examiner	Art Unit	
Anabel M. Ton	2875	

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Class	Subclass	Date	Examiner
362	600-634	9/30/2005	AT
362	551,559		
	560,561		
359	227		
349	62-67		_

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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